## Search Notes



# Application/Control No.

10517075

Applicant(s)/Patent Under Reexamination

HENCH, JOHN J.

Examiner

Art Unit

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2614

## SEARCHED

| Class | Subclass                | Date      | Examiner |  |  |
|-------|-------------------------|-----------|----------|--|--|
| 370   | 276, 286, 287, 524      | 5/25/2009 | GG       |  |  |
| 375   | 220, 222, 227, 232, 219 | 5/25/2009 | GG       |  |  |
| 379   | 406.01                  | 5/25/2009 | GG       |  |  |

#### SEARCH NOTES

| Search Notes   | Date      | Examiner |
|--|-----------|----------|
| EAST (US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB) | 5/25/2009 | GG       |

#### INTERFERENCE SEARCH

|       | INTERCENCE SEARON |      |          |  |  |  |
|-------|-------------------|------|----------|--|--|--|
|       |                   |      |          |  |  |  |
| Class | Subclass          | Date | Examiner |  |  |  |
|       |                   |      |          |  |  |  |

/Gerald Gauthier/ Primary Examiner.Art Unit 2614

U.S. Patent and Trademark Office Part of Paper No.: 20090525